

**Linear Integrated Systems**

**LS OP-37**

**FEATURES:**

- Replaces AD-510, 517, 725  
PMI-Op27, Op37, Op07, Op05  
Linear Tech. Op27, Op37, Op07
- Low Noise .....  $3\text{nV}/\sqrt{\text{Hz}}$  @ 1kHz  
 $80\text{nVpp}$  (0.1Hz to 10Hz)
- Low Drift .....  $0.2\mu\text{V}/^\circ\text{C}$
- Low Vos .....  $10\mu\text{V}$
- Slew Rate .....  $17\text{V}/\mu\text{s}$
- High Open Loop Gain ..... 1.8 Meg.
- Gain Bandwidth ..... 63 Meg Hz
- Superior CMRR ..... 126dB @  $V_{cm}$  of  $\pm 11\text{V}$

**DESCRIPTION:**

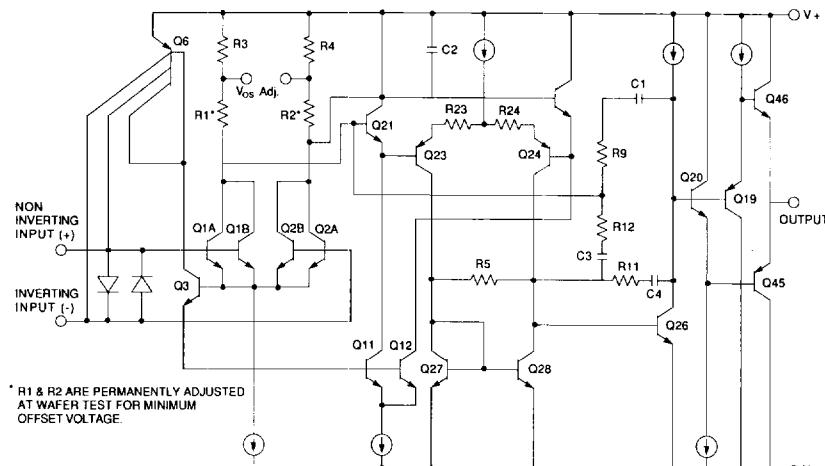
The Op-37 provides the same high performance as the Op-27 but the design is optimized for circuits with gains greater than five. This design change increases slew rate to  $17\text{V}/\mu\text{s}$  and gain-bandwidth product to 63MHz. The Op-37 operational amplifier combines outstanding low noise performance with precision D.C. characteristics and high speed operation. Wideband noise is  $3\text{nV}/\sqrt{\text{Hz}}$  at 10Hz., with a low 1/f noise corner frequency of 2.7Hz. The Op-37's exceptionally low noise process allows for accurate high-gain amplification of low level signals. A gain-bandwidth product of 63MHz and a  $17\text{V}/\mu\text{sec}$  slew rate provides excellent choice for reliable,

precision amplifier applications. The low input bias current of  $10\text{nA}$  and offset current of  $7\text{nA}$  are achieved by using a bias-current-cancellation circuit. Over the military temperature range this typically holds I-bias and I-os to  $20\text{nA}$  and  $15\text{nA}$  respectively. PSRR and CMRR exceed 120dB. These characteristics coupled with long-term drift of  $0.2\mu\text{V}/\text{month}$ , allow the circuit designer to achieve performance levels previously attained by discrete designs.

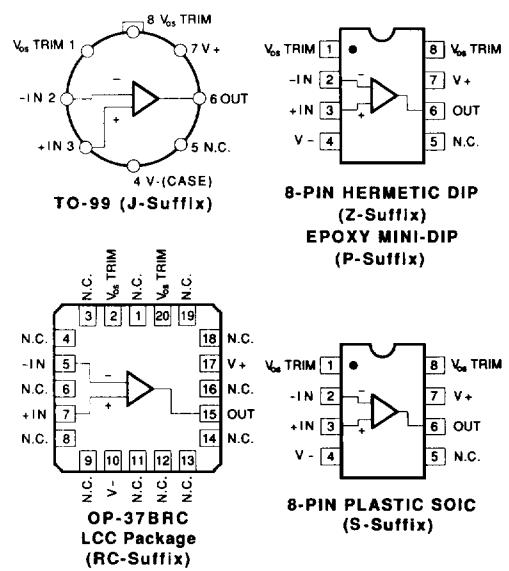
**PRODUCT HIGHLIGHTS:**

1. Precision amplification of very low level, low frequency voltage inputs is enhanced by ultra-low input voltage noise.
2. The Op-37 maintains high dc accuracy due to ultra-low offset voltage, offset voltage drift and input bias current.
3. Internal frequency compensation, factory adjusted offset voltage (zener-zapped) and full device protection eliminate the need for additional components.
4. Long-term stability and accuracy is assured with low offset voltage drift over time.
5. Input errors are greatly reduced by superior common mode and power supply rejection.
6. Radiation hardenable; contact factory.

**SIMPLIFIED SCHEMATIC**



**PIN CONNECTIONS**



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**LS OP-37**

## ABSOLUTE MAXIMUM RATINGS (Note 4)

Supply Voltage . . . . .	$\pm 22$
Internal Power Dissipation (Note 1) . . . . .	500mW
Input Voltage (Note 3) . . . . .	$\pm 22V$
Output Short-Circuit Duration . . . . .	Indefinite
Differential Input Voltage (Note 2) . . . . .	$\pm 0.7V$
Differential Input Current (Note 2) . . . . .	$\pm 25mA$
Storage Temperature Range . . . . .	-65°C to +150°C

## Operating Temperature

Op-37A, Op-37B, Op-37C (J, Z, RC) . . . . .	-55°C to +125°C
Op-37E, Op-37F, Op-37G (J, Z) . . . . .	-25°C to +85°C
Op-37E, Op-37F, Op-37G (P, S) . . . . .	0°C to +70°C
Lead Temperature Range (Soldering, 60 sec) . . . . .	300°C
DICE Junction Temperature . . . . .	-65°C to +150°C

## NOTES:

1. See table for maximum ambient temperature rating and derating factor.

PACKAGE TYPE	MAXIMUM AMBIENT TEMPERATURE FOR RATING	DERATE ABOVE MAXIMUM AMBIENT TEMPERATURE
T0-99 (J)	80°C	7.1mW/°C
8-Pin Hermetic DIP (Z)	75°C	6.7mW/°C
8-Pin Plastic SOIC (S)	62°C	5.6mW/°C
8-Pin Plastic DIP (P)	62°C	5.7mW/°C
LCC	80°C	7.8mW/°C

2. The OP-37's inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise. If differential input voltage exceeds  $\pm 0.7V$ , the input current should be limited to 25mA.

3. For supply voltages less than  $\pm 22V$ , the absolute maximum input voltage is equal to the supply voltage.

4. Absolute maximum ratings apply to both DICE and packaged parts, unless otherwise noted.

5. If Military/Aerospace specified devices are required, contact the Linear Systems Sales Office for availability and specifications.

## ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$ , $T_A = 25^\circ C$ , unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-37A/E			OP-37B/F			OP-37C/G			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
Input Offset Voltage	$V_{OS}$	(Note 1)	—	10	25	—	20	60	—	30	100	$\mu V$
Long-Term $V_{OS}$ Stability	$V_{OS}/Time$	(Notes 2, 3)	—	0.2	1.0	—	0.3	1.5	—	0.4	2.0	$\mu V/Mo$
Input Offset Current	$I_{OS}$		—	7	35	—	9	50	—	12	75	nA
Input Bias Current	$I_B$		—	$\pm 10$	$\pm 40$	—	$\pm 12$	$\pm 55$	—	$\pm 15$	$\pm 80$	nA
Input Noise Voltage	$e_{nV-p-p}$	0.1Hz to 10Hz (Notes 3, 5)	—	0.08	0.18	—	0.08	0.18	—	0.09	0.25	$\mu V_{p-p}$
Input Noise Voltage Density	$e_n$	$f_O = 10Hz$ (Note 3)	—	3.5	5.5	—	3.5	5.5	—	3.8	8.0	
		$f_O = 30Hz$ (Note 3)	—	3.1	4.5	—	3.1	4.5	—	3.3	5.6	$nV/\sqrt{Hz}$
		$f_O = 1000Hz$ (Note 3)	—	3.0	3.8	—	3.0	3.8	—	3.2	4.5	
Input Noise Current Density	$i_n$	$f_O = 10Hz$ (Notes 3, 6)	—	1.7	4.0	—	1.7	4.0	—	1.7	—	
		$f_O = 30Hz$ (Notes 3, 6)	—	1.0	2.3	—	1.0	2.3	—	1.0	—	$pA/\sqrt{Hz}$
		$f_O = 1000Hz$ (Notes 3, 6)	—	0.4	0.6	—	0.4	0.6	—	0.4	0.6	
Input Resistance — Differential-Mode	$R_{IN}$	(Note 7)	1.3	6	—	0.94	5	—	0.7	4	—	$M\Omega$
Input Resistance — Common-Mode	$R_{INCM}$		—	3	—	—	2.5	—	—	2	—	$G\Omega$
Input Voltage Range	IVR		$\pm 11.0$	$\pm 12.3$	—	$\pm 11.0$	$\pm 12.3$	—	$\pm 11.0$	$\pm 12.3$	—	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 11V$	114	126	—	106	123	—	100	120	—	dB
Power Supply Rejection Ratio	PSSR	$V_S \pm 4V$ to $\pm 18V$	—	1	10	—	1	10	—	2	20	$\mu V/V$
Large-Signal Voltage Gain	$A_{vO}$	$R_L \geq 2k\Omega$ , $V_O = \pm 10V$	1000	1800	—	1000	1800	—	700	1500	—	
		$R_L \geq 1k\Omega$ , $V_O = \pm 10V$	800	1500	—	800	1500	—	400	1500	—	$V/mV$
		$R_L = 600\Omega$ , $V_O \pm 1V$ , $V_S = \pm 4V$ , (Note 4)	250	700	—	250	700	—	200	500	—	
Output Voltage Swing	$V_O$	$R_L \geq 2k\Omega$	$\pm 12.0$	$\pm 13.8$	—	$\pm 12.0$	$\pm 13.8$	—	$\pm 11.5$	$\pm 13.5$	—	
		$R_L \geq 600\Omega$	$\pm 10.0$	$\pm 11.5$	—	$\pm 10.0$	$\pm 11.5$	—	$\pm 10.0$	$\pm 11.5$	—	V
Slew Rate	SR	$R_L \geq 2k\Omega$ (Note 4)	11	17	—	11	17	—	11	17	—	$V/\mu s$
Gain Bandwidth Prod.	GBW	$f_O = 10kHz$ (Note 4)	45	63	—	45	63	—	45	63	—	Mhz
		$f_O = 1MHz$	—	40	—	—	40	—	—	40	—	
Open-Loop Output Resistance	$R_O$	$V_O = 0$ , $I_O = 0$	—	70	—	—	70	—	—	70	—	$\Omega$
Power Consumption	$P_d$	$V_O = 0$	—	90	140	—	90	140	—	100	170	mW
Offset Adjustment Range	$R_p$	$R_p = 10k\Omega$	—	$\pm 4.0$	—	—	$\pm 4.0$	—	—	$\pm 4.0$	—	mV

## NOTES:

1. Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power. A/E grades guaranteed fully warmed up.
2. Long-term input offset voltage stability refers to the average trend line of  $V_{OS}$ . Time over extended periods after the first 30 days of operation. Excluding the initial hour of operation, changes in  $V_{OS}$  during the first 30

days are typically  $2.5\mu V$  — refer to typical performance curve.

3. Sample tested.

4. Guaranteed by design.

5. See test circuit and frequency response curve for 0.1Hz tester.

6. See test circuit for current noise measurement.

7. Guaranteed by input bias current.

# Linear Integrated Systems

**LS OP-37**

**ELECTRICAL CHARACTERISTICS** for  $V_S = \pm 15V$ ,  $-55^\circ C \leq T_A \leq +125^\circ C$ , unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-37A			OP-37B			OP-37C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
Input Offset Voltage	$V_{OS}$	(Note 1)	—	30	60	—	50	200	—	70	300	$\mu V$
Average Input Offset Drift	$TCV_{OS}$	(Note 2)	—	0.2	0.6	—	0.3	1.3	—	0.4	1.8	$\mu V/^\circ C$
Input Offset Current	$I_{OS}$		—	15	50	—	22	85	—	30	135	nA
Input Bias Current	$I_B$		—	$\pm 20$	$\pm 60$	—	$\pm 28$	$\pm 95$	—	$\pm 35$	$\pm 150$	nA
Input Voltage Range	IVR		$\pm 10.3$	$\pm 11.5$	—	$\pm 10.3$	$\pm 11.5$	—	$\pm 10.2$	$\pm 11.5$	—	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 10V$	108	122	—	100	119	—	94	116	—	dB
Power Supply Rejection Ratio	PSRR	$V_S = \pm 4.5V$ to $\pm 18V$	—	2	16	—	2	20	—	4	51	$\mu V/V$
Large-Signal Voltage Gain	$A_{VO}$	$R_L \geq 2k\Omega$ , $V_O = \pm 10V$	600	1200	—	500	1000	—	300	800	—	V/mV
Output Voltage Swing	$V_O$	$R_L \geq 2k\Omega$	$\pm 11.5$	$\pm 13.5$	—	$\pm 11.0$	$\pm 13.2$	—	$\pm 10.5$	$\pm 13.0$	—	V

**ELECTRICAL CHARACTERISTICS** for  $V_S = \pm 15V$ ,  $-25^\circ C \leq T_A \leq +85^\circ C$  for OP-37J and OP-37Z,  $0^\circ C \leq T_A \leq +70^\circ C$  for OP-37P, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-37E			OP-37F			OP-37G			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
Input Offset Voltage	$V_{OS}$		—	20	50	—	40	140	—	55	220	$\mu V$
Average Input Offset Drift	$TCV_{OS}$	(Note 2)	—	0.2	0.6	—	0.3	1.3	—	0.4	1.8	$\mu V/^\circ C$
Input Offset Current	$I_{OS}$		—	10	50	—	14	85	—	20	135	nA
Input Bias Current	$I_B$		—	$\pm 14$	$\pm 60$	—	$\pm 18$	$\pm 95$	—	$\pm 25$	$\pm 150$	nA
Input Voltage Range	IVR		$\pm 10.5$	$\pm 11.8$	—	$\pm 10.5$	$\pm 11.8$	—	$\pm 10.5$	$\pm 11.8$	—	V
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 10V$	110	124	—	102	121	—	96	118	—	dB
Power Supply Rejection Ratio	PSRR	$V_S = \pm 4.5V$ to $\pm 18V$	—	2	15	—	2	16	—	2	32	$\mu V/V$
Large-Signal Voltage Gain	$A_{VO}$	$R_L \geq 2k\Omega$ , $V_O = \pm 10V$	750	1500	—	700	1300	—	450	1000	—	V/mV
Output Voltage Swing	$V_O$	$R_L \geq 2k\Omega$	$\pm 11.7$	$\pm 13.6$	—	$\pm 11.4$	$\pm 13.5$	—	$\pm 11.0$	$\pm 13.3$	—	V

**NOTES:**

1. Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power. A/E grades guaranteed fully warmed up.

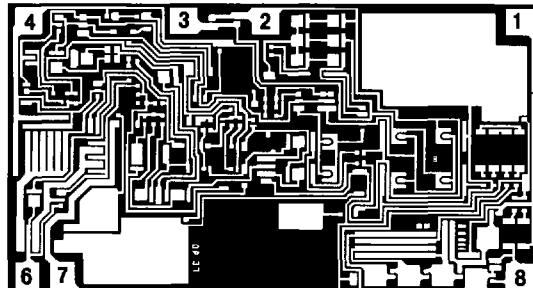
2. The  $TCV_{OS}$  performance is within the specifications unnullled or when nulled with  $R_p = 8k\Omega$  to  $20k\Omega$ .  $TCV_{OS}$  is 100% tested for A/E grades, sample tested for B/C/F/G grades.

3. Guaranteed by design.

## DICE CHARACTERISTICS

DIE SIZE 0.057x0.099 inch, 5643 sq. mils  
(1.44x2.57mm, 3.62 sq. mm)

For additional DICE information contact factory.



1. NULL
2. (-) INPUT
3. (+) INPUT
4. V-
6. OUTPUT
7. V+
8. NULL

# Linear Integrated Systems

**LS OP-37**

**WAFER TEST LIMITS** at  $V_S = \pm 15V$ ,  $T_A = 25^\circ C$  for OP-37N, OP-37G and OP-37GR devices;  $T_A = 125^\circ C$  for OP-37NT and OP-37GT devices, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-37NT LIMIT	OP-37N LIMIT	OP-37GT LIMIT	OP-37G LIMIT	OP-37GR LIMIT	UNITS
Input Offset Voltage	$V_{OS}$	(Note 1)	60	35	200	60	100	$\mu V$ MAX
Input Offset Current	$I_{OS}$		50	35	85	50	75	nA MAX
Input Bias Current	$I_B$		$\pm 60$	$\pm 40$	$\pm 95$	$\pm 55$	$\pm 80$	nA MAX
Input Voltage Range	IVR		$\pm 10.3$	$\pm 11$	$\pm 10.3$	$\pm 11$	$\pm 11$	V MIN
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 11V$	108	114	100	106	100	dB MIN
Power Supply Rejection Ratio	PSRR	$T_A = 25^\circ C, V_S = \pm 4V$ to $\pm 18V$ $T_A = 125^\circ C, V_S = \pm 4V$ to $\pm 18V$	10 16	10 —	10 20	10 —	20 —	$\mu V/V$ MAX
Large-Signal Voltage Gain	$A_{VO}$	$R_L \geq 2k\Omega, V/O = \pm 10V$ $R_L \geq 1k\Omega, V_O = \pm 10V$	600 —	1000 800	500 —	1000 800	700 —	V/mV MIN
Output Voltage Swing	$V_O$	$R_L \geq 2k\Omega$ $R_L \geq 600\Omega$	$\pm 11.5$ —	$\pm 12.0$ $\pm 10.0$	$\pm 11.0$ —	$\pm 12.0$ $\pm 10.0$	$\pm 11.5$ $\pm 10.0$	V MIN
Power Consumption	$P_d$	$V_O = 0$	—	140	—	140	170	mW MAX

**NOTES:**

1. For  $25^\circ C$  characteristics of OP-37NT and OP-37GT devices, see OP-37N and OP-37G characteristics, respectively.

Electrical tests are performed at wafer probe to the limits shown. Due to

variations in assembly methods and normal yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualification through sample lot assembly and testing.

**TYPICAL ELECTRICAL CHARACTERISTICS** at  $V_S = \pm 15V$ ,  $T_A = 25^\circ C$ , unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-37NT TYPICAL	OP-37N TYPICAL	OP-37GT TYPICAL	OP-37G TYPICAL	OP-37GR TYPICAL	UNITS
Average Input Offset Voltage Drift	$TCV_{OS}$ or $TCV_{OSn}$	Nulled or Unnulled $R_p = 8k\Omega$ to $20k\Omega$	0.2	0.2	0.3	0.3	0.4	$\mu V/\text{°C}$
Average Input Offset Current Drift	$TCI_{OS}$		80	80	130	130	180	pA/ $^\circ C$
Average Input Bias Current Drift	$TCI_B$		100	100	160	160	200	pA/ $^\circ C$
Input Noise Voltage Density	$e_n$	$f_O = 10Hz$ $f_O = 30Hz$ $f_O = 1000Hz$	3.5 3.1 3.0	3.5 3.1 3.0	3.5 3.1 3.0	3.5 3.1 3.0	3.8 3.3 3.2	$nV\sqrt{\text{Hz}}$
Input Noise Current Density	$i_n$	$f_O = 10Hz$ $f_O = 30Hz$ $f_O = 1000Hz$	1.7 1.0 0.4	1.7 1.0 0.4	1.7 1.0 0.4	1.7 1.0 0.4	1.7 1.0 0.4	pA/ $\sqrt{\text{Hz}}$
Input Noise Voltage	$e_{np-p}$	0.1Hz to 10Hz	0.08	0.08	0.08	0.08	0.09	$\mu V_{p-p}$
Slew Rate	SR	$R_L \geq 2k\Omega$	17	17	17	17	17	V/ $\mu s$
Gain Bandwidth Product	GBW	$f_O = 10Khz$	63	63	63	63	63	MHz

**NOTES:**

1. Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power.

## ORDERING INFORMATION

$T_A = 25^\circ C$ $V_{OSMAX}$ ( $\mu V$ )	PACKAGE					OPERATING TEMP RANGE
	HERMETIC TO-99 8-PIN	HERMETIC DIP 8-PIN	PLASTIC DIP 8-PIN	PLASTIC SO-JEDEC 8-PIN	LCC	
25	OP37AJ	OP37AZ				MIL
25	OP37EJ	OP37EZ	OP37EP	OP37ES		IND./COM.
60	OP37BJ	OP37BZ				MIL
60	OP37FJ	OP37FZ	OP37FP	OP37FS		IND./COM.
100	OP37CJ	OP37CZ				MIL
100	OP37GJ	OP37GZ	OP37GP	OP37GS		IND./COM.
					OP37BRC/88	

# Linear Integrated Systems

47853 Warm Springs Blvd.  
Fremont, Calif. 94539  
Tel: 415 659-1015  
Fax: 415 659-1365

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